## **PATENT**

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Wang et al.

Serial No.: TBA

Group Art Unit: TBA

Atty. Docket No.: 140-099

Filed: September 26, 2003

Examiner: TBA

For: APPARATUS AND METHOD FOR

ANALYZING SAMPLES IN A DUAL ION

TRAP MASS SPECTROMETER

Honorable Commissioner of Patents and Trademarks P.O. Box 1450 Alexandria, VA 22313-1450

## PRELIMINARY AMENDMENT

SIR:

Prior to substantive review of the subject application, please amend as follows: